

H3D010170D

Product Summary

V_{RRM}	=	1700	V
$I_{F(AVG)}$	=	10	A
Q_C	=	106	nC

Part Number
Die Size

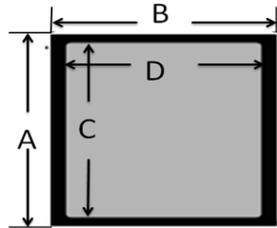
H3D010170D

3.00mm x 3.00mm

Mechanical Parameters

Parameter	Typ.	Unit
Die Size	3.00x3.00	mm ²
Anode Pad Opening	2.07x2.07	mm ²
Thickness	350±50	µm
Wafer Size	100	mm
Anode Metallization (Al)	4	µm
Cathode Metallization (Ni/Ag)	1.6	µm
Frontside Passivation	Polyimide	

Chip Dimensions



Symbol	Dimension
A	3.00mm
B	3.00mm
C	2.07mm
D	2.07mm

Maximum Ratings

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{RRM}	Repetitive Peak Reverse Voltage	1700	V		
V_{DC}	DC Blocking Voltage	1700	V		
$I_{F(AVG)}$	Average Forward Current	10	A	$T_J = 175^\circ\text{C}$	
I_{FSM}	Non-Repetitive Forward Surge Current	110	A	$T_C = 25^\circ\text{C}$, $t_p = 8.3\text{ms}$, Half Sine Wave	1
T_J	Operating Junction Temperature	-55 to 175	°C		

1. Assumes Thermal Resistance of 0.5°C/W or less

Electrical Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_F	Forward Voltage	1.5 2.1	1.8 2.5	V	$I_F = 10\text{A}$, $T_J = 25^\circ\text{C}$ $I_F = 10\text{A}$, $T_J = 175^\circ\text{C}$	Fig.1
I_R	Reverse Current	5 25	50 200	µA	$V_R = 1700\text{V}$, $T_J = 25^\circ\text{C}$ $V_R = 1700\text{V}$, $T_J = 175^\circ\text{C}$	Fig.2
C	Total Capacitance	990 45 42	/	pF	$V_R = 0\text{V}$, $T_J = 25^\circ\text{C}$, $f = 1\text{MHz}$ $V_R = 800\text{V}$, $T_J = 25^\circ\text{C}$, $f = 1\text{MHz}$ $V_R = 1700\text{V}$, $T_J = 25^\circ\text{C}$, $f = 1\text{MHz}$	Fig.3
Q_C	Total Capacitive Charge	106	/	nC	$V_R = 1700\text{V}$, $I_F = 10\text{A}$ $di/dt = 200\text{A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$	Fig.4

Typical Performance

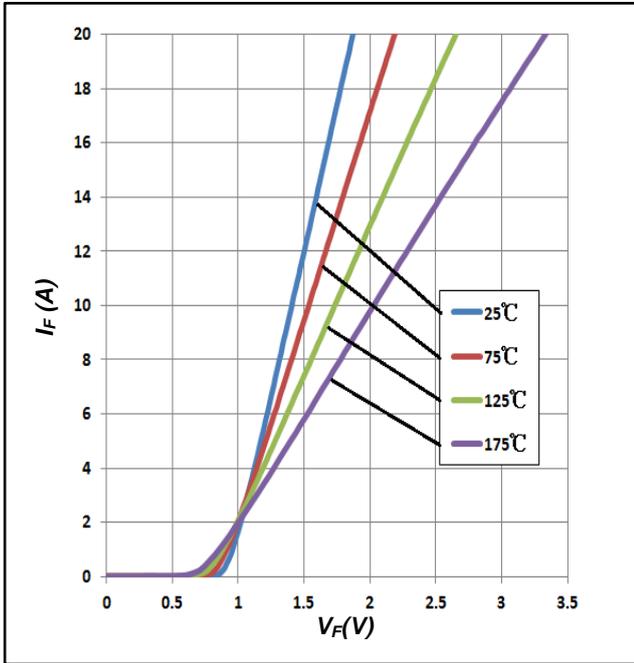


Figure 1. Forward Characteristics

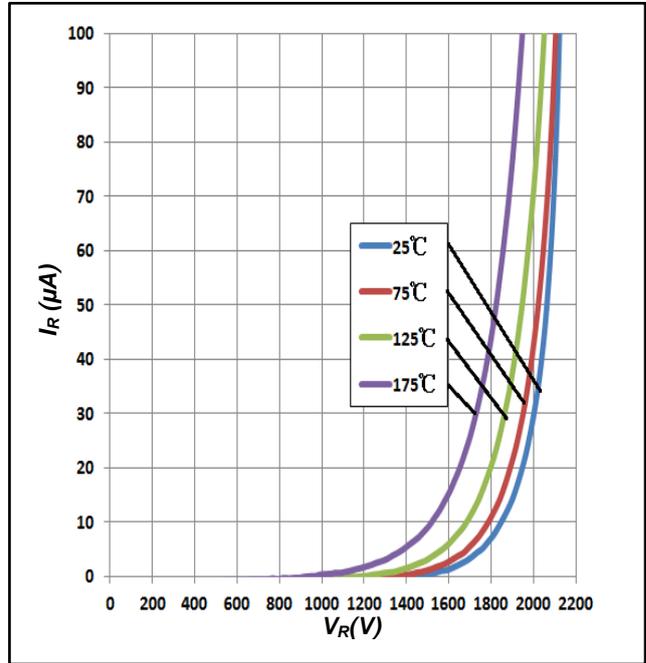


Figure 2. Reverse Characteristics

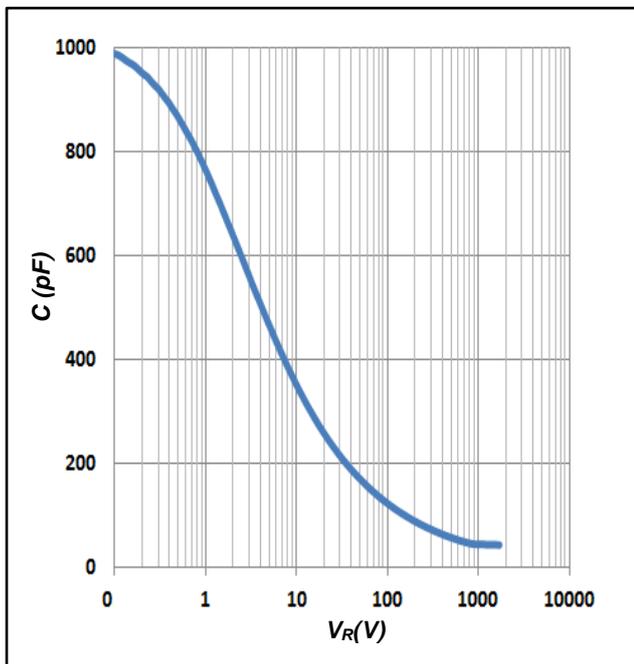


Figure 3. Total Capacitance vs. Reverse Voltage

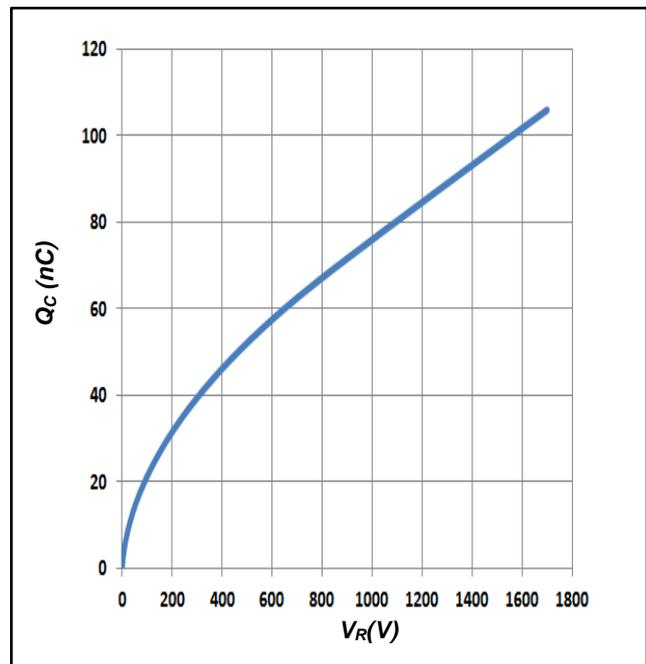


Figure 4. Total Capacitance Charge vs. Reverse Voltage